

Reaction-induced surface reconstruction of silver in contact with zirconium

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Abstract

When two solid metals are in contact at high temperature, interdiffusion occurs leading in some cases to the growth of intermetallic compounds. The study of nucleation, growth and properties of these intermetallic compounds are of interest since it can be critical for many applications in industries. Yet, the effect of these reactions on the initial surfaces of both metals is not well understood and particularly when surfaces are not perfectly flat and for short contact time. The purpose of the present study is to demonstrate that the growth of an intermetallic compound layer between two solid metals can lead to the surface reconstruction of one of them. The silver–zirconium system will be presented in order to illustrate this new phenomenon. The effect of contact point on the diffusion–reaction process has been modelled by patterning the Zr surface. The nucleation and growth of the intermetallic compounds occur along the contact points which leads to silver surface reconstruction with the growth of the preferential crystal planes {111} and {100}. A model explaining this new phenomenon is developed based on the minimisation of Gibbs energy and the diffusion rates of both Ag & Zr atoms in the binary system Ag/Zr.

Keywords: Silver, Zirconium, Interdiffusion, Surface, Intermetallic compounds

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1. Introduction

The solid state diffusion between two metals is a common process used in many industrial situations such as diffusion bonding between two metals of different nature [1, 2]. This process leads sometimes to the formation of intermetallic compound layers (IMCs). The nucleation and growth of these IMCs layers are of interest since these intermetallic compounds provide a good bond between the metals but are generally brittle and may lead to failure in the final product.

Silver is a metal of interest for many industries including dentistry where silver is alloyed with mercury for amalgams [3, 4, 5], microelectronics for solder purposes [6, 7, 8, 9] and the nuclear industry where silver is used to make control rods in nuclear reactors thanks to the capability of silver to absorb free neutrons [10, 11]. Moreover, the catalytic properties of silver are widely used by the chemical industry for the epoxidation of ethylene or the partial oxidation of methanol to formaldehyde [12, 13, 14]. Recently, an increased interest has been observed for silver substrates textured for the growth of high temperature superconductors [15, 16, 17]. Finally, the anti-microbial activity of silver has been explored for (bio-) nano-technologies [18, 19, 20].

In many of these applications, silver is in contact at elevated temperature with another metal and solid state diffusion occurs, involving directly the silver surface and its properties. It is therefore important to study the contact between the silver and a

metal at elevated temperature. However, when silver is heated under its melting point (e.g. $T < 873$ K), the surface undergoes pronounced morphological changes. These changes are gathered under the term "etching" and have been extensively studied since the early of the 20th century [21, 22, 23].

The etching of silver includes grain-boundary grooving [24], etch pitting [25, 26] and faceting [27] and can be induced by temperature –thermal etching– and/or by reaction –catalytic etching [28, 29]. The mechanisms of Ag surface reconstruction can be described from a thermodynamic point of view, the driving force being the minimisation of the total Gibbs energy [30]. However, the kinetics of silver atom evaporation has also to be taken into account especially when dealing with heat treatments under vacuum [31, 32]. Multiple parameters can impact the etching of silver. In addition to time and temperature, the presence of oxygen in the atmosphere surrounding the silver surface is known to enhance drastically the faceting and grain-boundary grooving [27, 29]. That is why extensive researches have been done in order to understand the key role of adsorbed oxygen and subsurface oxygen on these morphology changes during catalytic reactions [33, 34, 35].

In order to understand the impact of etching and reaction on the surface of silver at elevated temperature, it has been chosen to study the contact reaction between solid silver and a model metal—here zirconium.

The silver/zirconium system was first described by Karlsson in 1952 [36], with two different non-stoichiometric intermetallic compounds (IMCs) AgZr and AgZr₃. However, the most recent studies based on theoretical [37, 38] and experimental [39, 40] investigations contested this early study, and nowa-

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days two stoichiometric IMCs are generally accepted: tetragonal AgZr and AgZr₂, with Strukturbericht Symbol B11 and C11_b, respectively. According to Taguchi & Iijima [39] in the Ag/Zr couple, the diffusion flux of Ag atoms is larger than that of Zr atoms, which corroborates the multiple results of self-diffusion measurements of Ag tracers in bulk Zr [41, 42, 43].

One can assume that contact reaction at high temperature between silver and zirconium will then lead to the formation of two IMCs, AgZr and AgZr₂. However, no evidence of silver surface reconstruction has been reported in the literature yet [39, 40]. This is quite understandable as the study of solid state diffusion between a couple of materials is generally carried out by using (i) laboratory-polished surfaces, (ii) similar sample size, (iii) high applied pressure between the two materials (screw), (iv) long diffusion time and (v) by characterising only the cross-section of the interface.

Nevertheless, in many industrial situations all these conditions are not fulfilled. For example, materials are generally not polished, therefore the surface roughness can be high. Also, in some cases the force applied between two materials can be small and/or non-uniform, compared to a diffusion couple pressed by screws. Finally, edge effects are not taken into account in diffusion couples, although they can be important for industrial geometries.

The purpose of this paper is to demonstrate the impact of the contact reaction between silver and zirconium at elevated temperature and the etching of silver on the morphology of Ag surface.

2. Experimental

The experimental part of this study lies on annealing experiments under vacuum of Ag/Zr couples. The effect of contact between Ag and Zr has been modelled by using patterned zirconium and polished silver, as described below.

2.1. Material preparation

10 × 8 mm coupons of polycrystalline (grain size 20 μm) rolled silver sheets of 0.5 mm thickness and with a purity of 99.99 % were used for this study. The main impurities of silver sheets are oxygen (20–27 wtppm), lead (14 wtppm) and copper (13 wtppm), and the description of silver sheets processing can be found elsewhere [44]. In order to remove any damage and contamination coming from the rolling process, the surface of the silver coupons was polished as follows: firstly coupons were ground using SiC papers down to "2000 grit" size. Silver samples were then polished using diamond suspensions of 6 μm, 3 μm, 1 μm and finally 0.25 μm. After polishing, silver samples were cleaned using ultrasonic bath of different alcohols in order to remove dusts and organic pollutants.

In order to study the effect of point contact on the Ag/Zr diffusion couple, zirconium samples were patterned with an array of 1 μm-high ridges spaced every 120 μm. This patterning was performed as follows. A 500 × 500 × 1 mm zirconium sheet supplied by Goodfellow (purity of 99.2 % – main impurities:

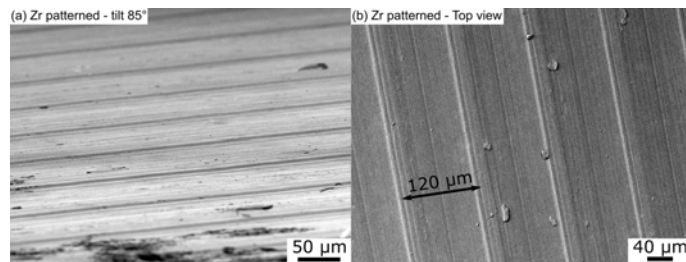


Figure 1: SEM images of the surface of zirconium patterned with an array of 1 μm-high ridges spaced every 120 μm. (a) tilt 85. (b) Top view

hafnium 2500 wtppm and oxygen 1000 wtppm. Grain size 10–20 μm) was fixed on a rotating stage, while a fine tip was engraving the zirconium surface. The Zr sheet was then removed and cut into 12 × 2 × 1 mm rods. Dusts and organic pollutants from the machining process were finally removed using a cleaning process consisting of ultrasonic baths with different alcohols. Figure 1 shows SEM images of the patterned Zr surface where ridges are easily recognisable.

For comparison, some zirconium samples were also polished prior to the Ag/Zr couples annealing. The polishing process of zirconium samples was made of a first grinding step using SiC papers down to "4000 grit" size. A second polishing step using a mixture of a suspension of silica particles (OP-S, from Struers) diluted in deionized water and hydrogen peroxide with a volumetric ratio 5:6:1. This polishing step was made on a MD-Chem pad (Struers) and lasted up to 2 hours.

2.2. Annealing experiments

Once prepared, the Ag and Zr samples were set in a stainless steel holder and pressed by screws. Annealing experiments of the Ag/Zr couples were performed in a hot-wall alumina tube furnace equipped upstream with a gas panel and downstream with a pumping system. The furnace had a type-K thermocouple directly inserted in the hot zone of the furnace. Before reaching the working pressure of 1 Pa, the furnace was filled with argon (99.998 %) then purged twice. Heat treatment experiments were then carried out at different temperatures (from 673 to 1073 K) and for different dwell times (from 1 min to 96 hours). The ramp-up was fixed at 20 K.min⁻¹.

After annealing, the Ag/Zr couples were cooled-down slowly. Samples were examined in two configurations. (i) Some samples were studied in cross-section, similar to the standard method used in the study of reactive diffusion, soldering and brazing. This involved mounting in cold resin and polishing with diamond solutions to reveal the Ag-IMC-Zr cross-sections. This configuration was particularly adapted for classical polished Ag/polished Zr couples. (ii) For other samples, a technique was developed to detach the Ag and Zr sheets after the heat treatment and to study their surfaces directly. This technique was possible here because most of the time, polished Ag & patterned Zr couples were not or slightly bonded in the experimental conditions studied here (Ag & patterned Zr sheets were detached manually, while a screw was used to separate polished Ag & polished Zr). This configuration was found to be useful

at revealing the contact reaction mechanisms. The different surfaces and interfaces were then characterised by Scanning Electron Microscopy (FEG-SEM, Zeiss Auriga), Energy Dispersive X-ray spectroscopy (EDX, Oxford Instruments) and Electron Back-Scattered Diffraction (EBSD, Quantax Bruker). The sub-surface of both silver and zirconium were also investigated by dual column focussed ion beam/SEM microscopy (FIB-SEM, FEI Helios NanoLab 600).

3. Results & Discussion

3.1. Solid state diffusion between polished Ag & polished Zr

As it can be seen on Figure 2(a) when polished Ag and Zr samples are heat treated at 1073 K for 720 min under vacuum, reactive interdiffusion occurs, leading to the formation of intermetallic layers composed of AgZr and AgZr₂. The EDX spectrum (Fig. 2(b)) and semi-quantification give values for the AgZr layer (50.75 at.% Zr, 49.25 at.% Ag), and the AgZr₂ layer (67.63 at.% Zr, 32.37 at.% Ag). The measured thickness of the layers are $\approx 13 \mu\text{m}$ and $\approx 1 \mu\text{m}$, for AgZr and AgZr₂ respectively. These values are slightly smaller than the predicted values obtained from the experimental results of Taguchi & Iijima [39], but it can be explained by the fact that the time range studied here is outside the time range of Taguchi & Iijima, therefore the calculated thickness are not accurate. Moreover, for short annealing time, the kinetics of reaction may be different than in the steady state regime.

From the cross-section observation (Fig. 2(a)), no notable surface reconstruction either on Ag or Zr side can be seen. When such Ag/Zr samples are detached, it is possible to look directly at the surface of both Ag and Zr. In the middle of the samples, no characteristic reconstruction is observed, except the dimples due to detachment leading to a mechanic deformation of the Ag. Most of the IMC layer is found on the Zr side (Fig. 2(d)), although on the silver side particles can be seen, suggesting a strong adhesion of the IMCs layer between Ag and Zr which is conclusive with the necessity to use tools to detach Ag and Zr (Fig 2(c)).

3.2. Solid state diffusion between polished Ag & patterned Zr

In this section the results of annealing experiments done with polished Ag & patterned Zr samples will be presented. When necessary, it has been chosen to detach Ag and Zr samples in order to characterise the surfaces. SEM mapping of Ag & Zr surfaces has been performed focussing on a zone previously in contact, and using ImageJ to stitch the different images in a larger one. For a better understanding, it has also been chosen to digitally flip Zr SEM images in order to allow a direct comparison between the morphologies observed on both Ag and Zr surfaces previously in contact. The authors strongly suggest the reader to print and/or zoom in Figures 3, 4, 5 and 6 while reading the present section.

Figures 3 and 4 show SEM images of Ag and Zr surfaces respectively of an Ag-Zr couple annealed at 973 K for 360 min under vacuum. The edge of the Zr rod is visible on the bottom part of the main SEM image on Figure 4. First it is noticeable

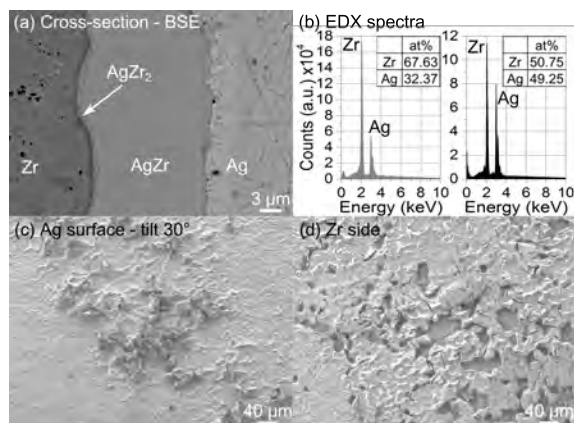


Figure 2: Contact reaction between polished Ag and polished Zr for 720 min at 1073 K, under vacuum ($P = 1 \text{ Pa}$). (a) Back-scattered SEM image of the interdiffusion zone between Ag and Zr. Two IMCs are visible, AgZr and AgZr₂. (b) EDX spectra of the AgZr₂ (grey) and AgZr (black) IMCs layer. (c) SEM image of the surface of Ag after being detached: IMCs particles can be observed. (d) SEM image of the Zr side, where a thick IMCs is visible. Holes due to IMCs stitched on the Ag surface are visible.

that both surfaces have been impacted by annealing. On the Ag side, the initial polished surface is greatly modified in the vicinity of the Zr contact, while an IMC layer has grown on the Zr side (note that IMC has not been found on the Ag surface). However all the surfaces are not impacted in the same way. The top of the SEM images show non-impacted Ag & Zr surfaces, which can be explained by an asymmetric contact between both metals, with a strong contact on the edge (see bottom of Ag side) and almost no contact on top of the image: the array of ridges is still visible on the Zr side and the smooth/flat surface of Ag (with annealing twins) can be seen in the top-left corner.

The main observation is that the contact points (i.e. Zr ridges) are the place where the IMC layer grows, which in turn modifies the Ag surface. Moreover, since different regions are at different stages of contact reaction and some surface regions are unreacted, this experiment reveals important details of the IMC nucleation and growth mechanisms in the early stages of a contact reaction. By comparing regions at different stages of the contact reaction, the sequence of events and reaction mechanisms can be inferred.

Three zones have been highlighted and magnified on Figures 3 and 4, each of them corresponding to a particular stage of IMC layer growth.

The first zone (a) displays a detail related to IMC nucleation on both surfaces. On the Zr side (Fig. 4a) one can see a circular protuberance. In mirror, a circular depression is observable on the Ag side (Fig. 3a). This particular morphology is interpreted as an IMCs in the early stage of nucleation localised at a contact point between Ag and Zr. This morphology will be extensively characterised in section 3.3.

In the second zone (b), it is possible to see on the Zr side (see Fig. 4b) multiple protuberances which have coalesced because of lateral growth. This growth is accompanied on the Ag surface by the formation of trenches and faceted pits due to surface diffusion of Ag atoms towards the intermetallic com-

pounds. The topography of the Ag surface does not match with the topography observed on the Zr surface. Moreover, these surface modifications occur not only under the IMC but also in the vicinity of the protuberance growth, suggesting a high mobility of Ag atoms on the surface. It is noteworthy that the faceted pits are comparable to the ones observed on a free Ag surface submitted to a thermal treatment under vacuum [45, 46, 44].

The last highlighted zone (c) is characterised by an IMC layer on the Zr side while the Ag surface is smoother (see Figs. 3c and 4c). The IMC layer growth may be controlled by a vertical growth, the lateral expansion being localised next to the contact points (see top-right corner of Figure 4). In mirror to the IMC layer, the surface morphology of silver may be explained by a smoothing effect on previously pitted surface: on the first steps of IMC nucleation and lateral growth, Ag atoms coming from the local Ag surface diffuse towards nucleation site, forming pits and facets in order to minimise the total Gibbs energy. While the IMC layer growth continues the faceted pits are covered with IMC thus the Ag surface is smoothed.

With the purpose of enhancing the surface modifications of silver surface in contact with patterned zirconium the temperature and time of Ag-Zr contact annealing was increased during another experiment to 1073 K and 720 min, respectively. The results of this experiment are presented on Figures 5 and 6 for Ag surface and Zr surface, respectively. For a better understanding, the SEM images of patterned Zr surface have been digitally flipped.

First, it is clear that both Ag and Zr surfaces have been deeply impacted by the diffusion annealing. On the Ag side, the surface is clearly modified and IMCs has grown on the Zr side. Also, the heterogeneity of surface morphologies observed can be explained by an asymmetric contact between Ag and Zr, with a stronger contact on the bottom-right corner than on the top-left corner. This hypothesis suggests it is possible to have a chronological approach within a single experiment. Four zones have been highlighted on the main SEM images, each will be discussed in turn.

On zone (a) it is possible to observe the early stage of nucleation of a protuberance on the Zr surface, with in mirror a small depression on the Ag side (see Fig. 5a and 6a).

Figure 6b shows a morphology not present at lower annealing temperature and time on Zr surface. This morphology develops between ridges and can be described as impinged particles. The growth of these particles may be explained by two factors: no contact between Ag and Zr between two ridges and a higher temperature leading to a high evaporation rate of Ag atoms, going to react with Zr on the opposite side. This hypothesis is also supported by the faceted pits found in mirror on the Ag side (see Fig. 5b), which can correspond to the morphology of the Ag surface after an evaporation process occurred.

Also, along the Ag-Zr contact zone (ridges) surface modifications became more complex as it can be seen on Figures 5c and 6c. On these ridges the IMC layer which grew on the Zr surface is thick and flat compared to the evaporation zones (between ridges), while the surface of Ag appears to be highly faceted with the presence of holes (see top-left corner of Fig. 5c). These holes are also faceted and may be interpreted as ab-

normal pitting. It can be assumed that the surface contact area between Ag and Zr in these zones consists only of edges-to-edges point contact since the morphologies of both Ag and Zr surfaces are not identical. The Ag faceting may be due to the minimization of the total Gibbs energy which is coupled with the diffusion-reaction of Ag atoms when the IMC grows.

In the bottom-left corner of Figure 6 both IMCs grown on the Zr surface, respectively between and at the ridges, merged and a uniform layer will grow (see Fig. 6d). On the other hand, the Ag surface is highly faceted showing little contact with the Zr surface (see Fig. 5d). For stronger contact (not shown here) the facets are less pronounced, and one can assume that the Ag surface has been smoothed by the growth of the IMC layer perpendicular to the Ag-Zr sheets.

3.3. Characterisation of protuberances

A SEM image at higher magnification of a typical protuberance is shown on Figure 7a. Its surface is rough and rings can be seen on the edges. These rings may be due to either growth steps or mechanical strain. Some silver particles also exist on top of this protuberance, as it can be seen from the side (see Fig. 7b). In order to have access to the whole protuberance morphology, a FIB sputter etching was carried out and cross-section SEM images recorded (see Fig. 7c). It is noteworthy that a thin layer is observable at the bottom of the protuberance (see arrow on Fig. 7c), suggesting the growth of two intermetallic compounds. With the purpose of correctly identify the composition of the main IMC of the protuberance, a FIB sputter etching was done parallel to the Zr surface and an EDX spectrum has been acquired (see Fig. 7d). The EDX semi-quantification gives 49,2 at% Ag and 50.8 at% Zr, which is consistent with AgZr.

The identification of the second IMC layer was possible by combining FIB-SEM sample preparation and EBSD. First a foil of the protuberance was lifted out using a FIB-SEM microscope and placed on a home-made specimen holder (see Fig. 8a). Then the protuberance cross-section surface was cleaned with FIB milling, whereby the current and the voltage of the ion beam was tuned from high values to low values at the end of the cleaning. The prepared specimen was then transferred to the SEM-EBSD microscope and an EBSD map was acquired. As it can be seen on the phase map in Figure 8c two phases are identified, corresponding to the two intermetallic compounds known in the literature: the main part of the protuberance is made of AgZr, while a thin layer of AgZr₂ is at the bottom (see Fig. 8b for the crystalline structure of these two compounds). The inverse pole figure along the x axis displayed on Figure 8 reveals that both AgZr and AgZr₂ are polycrystalline.

Based on Figures 7 and 8 as well as on the fact that Ag atoms diffuse faster than Zr atoms in Ag-Zr system [39], it can be inferred that most of IMCs growth takes place in the Zr sheets. This point explains why IMC layer is only found on the Zr side when Ag-Zr sheets are detached.

3.4. Ag faceting - EBSD characterisation

To understand the facets observed locally on the silver surface after annealing in contact with Zr (e.g. in Figure 5d) the

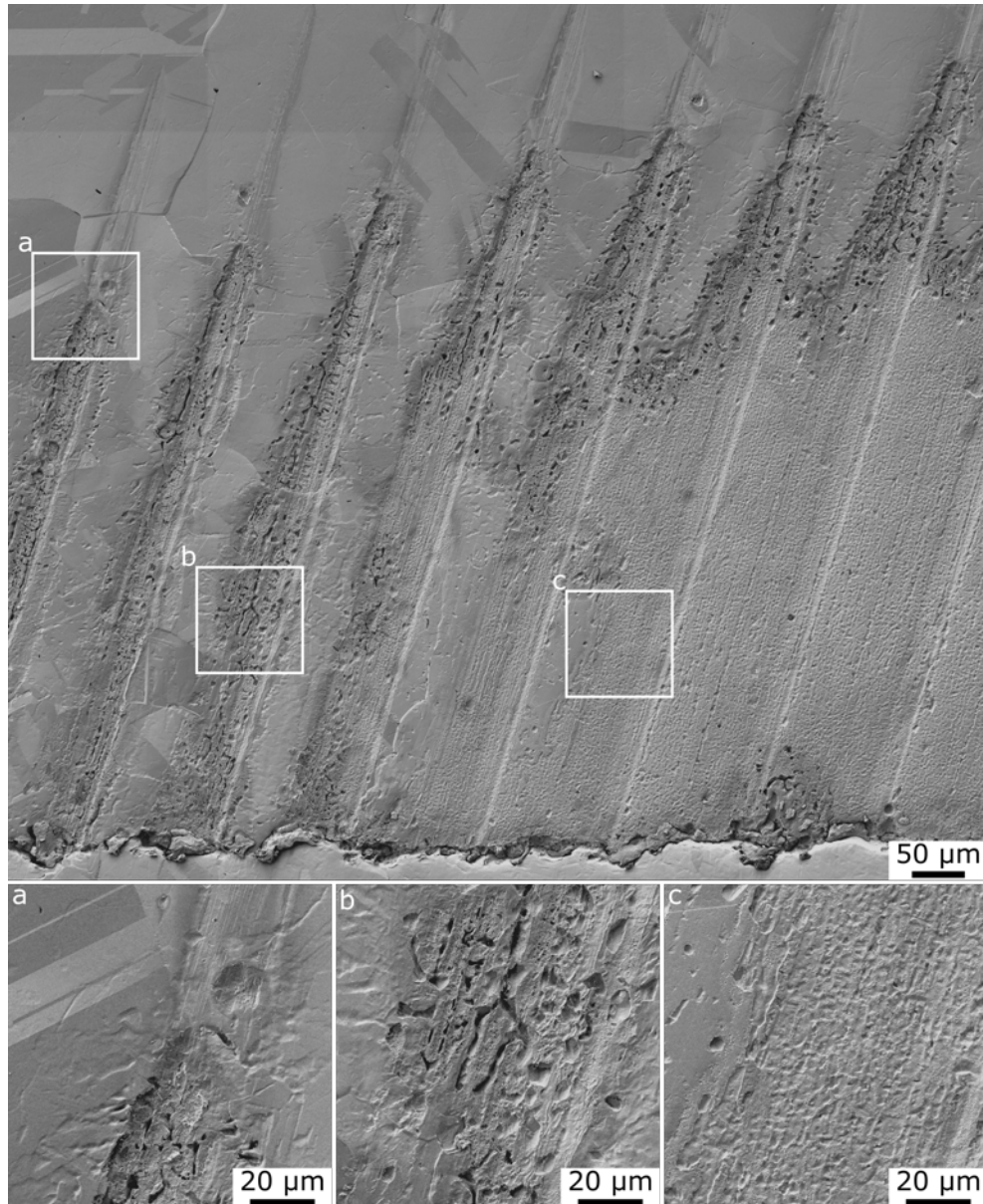


Figure 3: Polished Ag surface after annealing in contact with patterned Zr at 973 K for 360 min under vacuum ($P = 1$ Pa).

crystal planes of these facets were studied by EBSD. Figure 9a shows a SEM image of a faceted Ag zone where an EBSD acquisition has been done (dotted rectangle). Despite the non-flat surface, a large fraction of the Kikuchi patterns have been resolved as it can be seen from the inverse pole figure along the x axis presented in Figure 9b, the main dark regions being facets not scanned by the electron beam because of the 70 angle between the sample surface and the beam in the configuration of the EBSD detection. In the same way it has been possible to identify different grains (see Fig. 9c), each corresponding to a particular appearance of the facets. Thus, the crystal orientation of each grain can be determined and the crystal planes on the surface indirectly identified. Figure 9d displays the crystal orientation of Ag for the identified grains, where it can be inferred that the facets are the $\{111\}$ and $\{100\}$ family of planes.

Thus, similar to past studies on the thermal etching of Ag, the Ag faceting is consistent with the surface reconstruction to minimise the total Gibbs energy.

3.5. Model of surface reconstruction

To the best of our knowledge, the reconstruction of a surface during a solid state reaction diffusion process has not been described in the literature yet. This may be explained by the particular system described here: (i) Ag is known to etch thermally but Zr is not; (ii) Ag atom diffusion is faster than Zr atoms diffusion in the Ag/Zr couple; (iii) this study involved intermittent contact and regions without contact due to the use of the patterned Zr and Ag sheets, which is relevant to Ag in various industrial uses.

Based on the experiments and characterisation, a model of the surface modification for both Ag and Zr can be suggested.

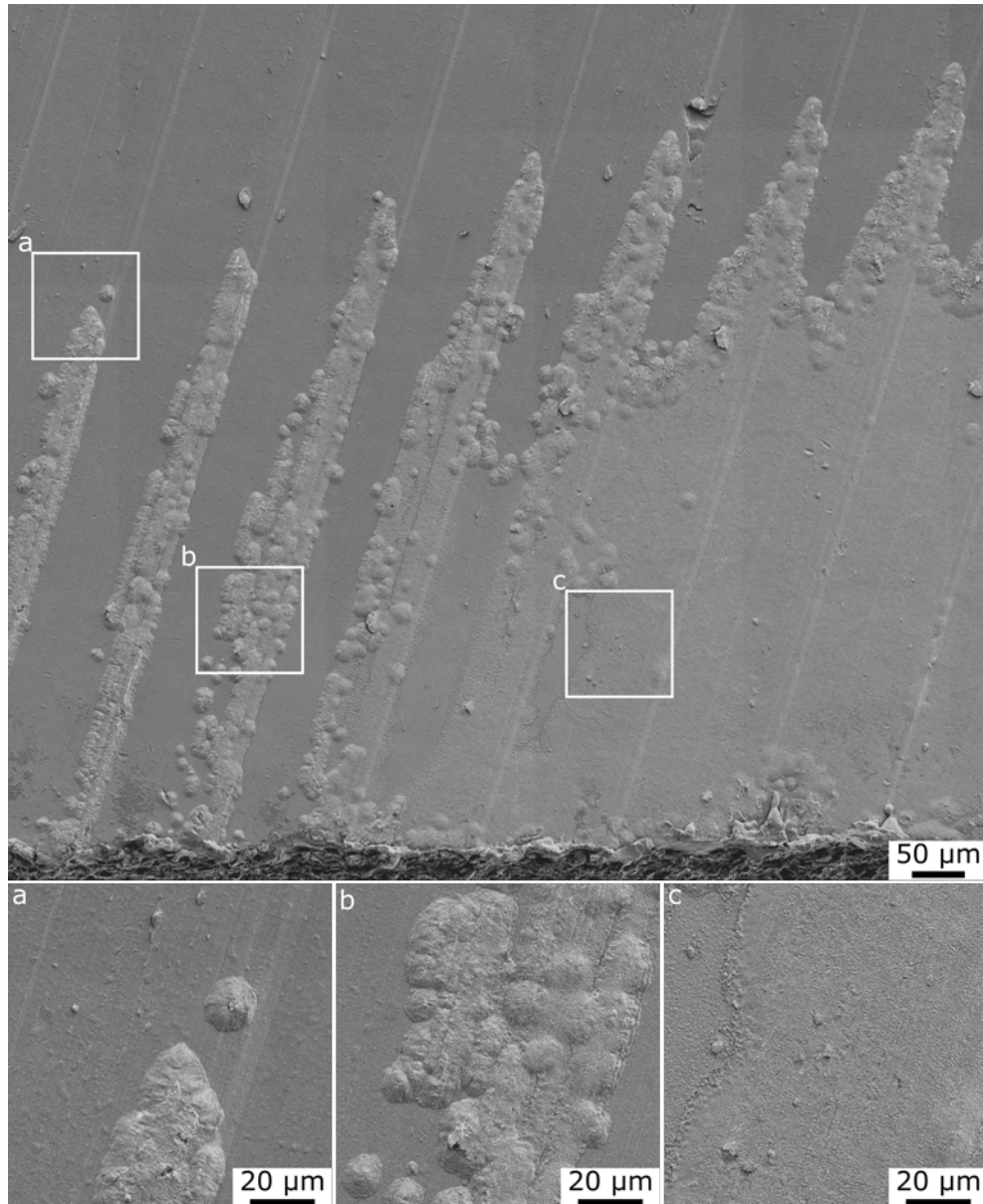


Figure 4: Flipped SEM images of patterned Zr surface after annealing in contact with polished Ag at 973 K for 360 min under vacuum ($P = 1$ Pa).

Initially the Ag-Zr couple is in contact only along the ridges on the patterned Zr and can be modelled in two dimensions as on Figure 10a, where the surface of Ag is flat (bottom) and the surface of Zr is patterned with triangular ridges (top).

When this system is held at high temperature, first the native oxide of silver Ag_2O decomposes into Ag and O_2 above 725 K [47, 48] and the native zirconium oxide ZrO_2 dissolves into the Zr as the solubility for O is relatively high at $T < 970$ K [49, 50]. Ag and Zr then react at the contact points, which occurs by the nucleation of intermetallic compounds in accordance with the Ag-Zr binary diagram. This nucleation is possible *via* the diffusion of Ag and Zr atoms as sketched on Figure 10b. Ag and Zr atoms move towards the Ag-Zr contact either by (1) surface diffusion, or (2) volume diffusion. The nucleated IMC then grows laterally in the form of a protuberance

(see Figs. 4a and 7).

In parallel, if the annealing temperature is sufficiently high (e.g. 1073 K) atom sublimation may occur away from the Ag-Zr contact, which leads to the nucleation of intermetallic compounds particles between ridges (see (3) on Fig. 10b). The melting point of Ag being lower than that of Zr, it can be assumed that the Ag sublimation rate is higher than that of Zr, thus the growth of IMC particles will take place on the Zr surface. This point is supported by the SEM observations (see Fig. 6).

With time, the nucleated IMCs protuberances and particles grow. This growth is accompanied by a surface reconstruction of silver which is driven by the minimisation of free energy, and leads to the preferential formation of high-density family planes in FCC crystals, i.e. $\{111\}$ and $\{100\}$ planes (see Fig 10c). Such reconstruction is common for silver surfaces alone and can take

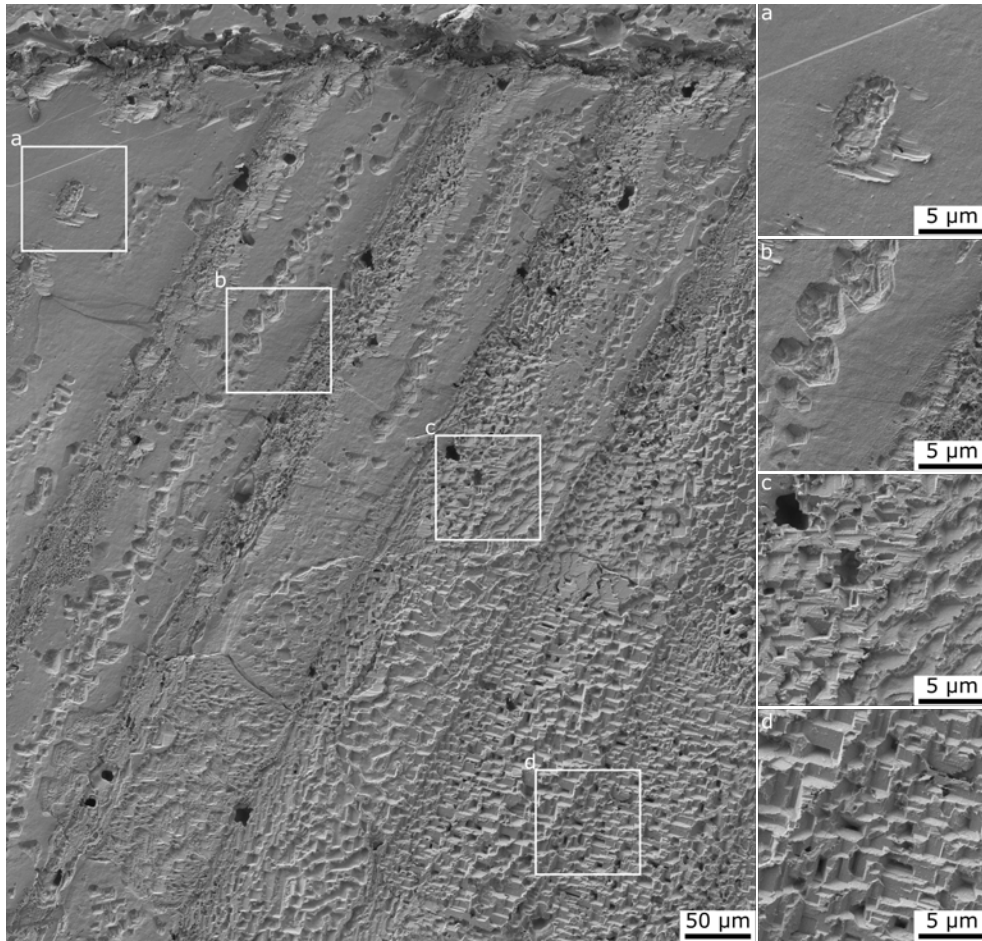


Figure 5: Polished Ag surface after annealing in contact with patterned Zr at 1073 K for 720 min under vacuum ($P = 1 \text{ Pa}$).

different forms, for example faceting or etch pitting [32, 51]. This phenomenon combines multiple mechanisms such as a high mobility of Ag atoms on the surface and Ag sublimation at high temperature. In the case of Ag-Zr contact reactions the Ag atoms are more mobile than Zr atoms, which explains the high reconstruction of the Ag surface observed on Figure 5 and 9a for example. The higher Ag diffusion can be deduced from the relative position of AgZr and AgZr_2 (see Figs. 2 and 8) as well as from the IMCs growth shifted in Zr (no IMCs found on Ag side, see Figs. 3 and 5).

Finally, the lateral growth of IMCs will eventually lead to the merging of discrete protuberances, so a full layer of intermetallic compounds will be formed. The reconstructed Ag surface is therefore covered by an intermetallic compounds layer, limiting the evaporation process as well as the diffusion length of Ag atoms before reaction with Zr, which in turn leads to the smoothing of Ag surface (see Fig. 10d). This possible mechanism is based in particular on the smooth surface of Ag observed where the Ag-Zr contact is strong (see for example 3c).

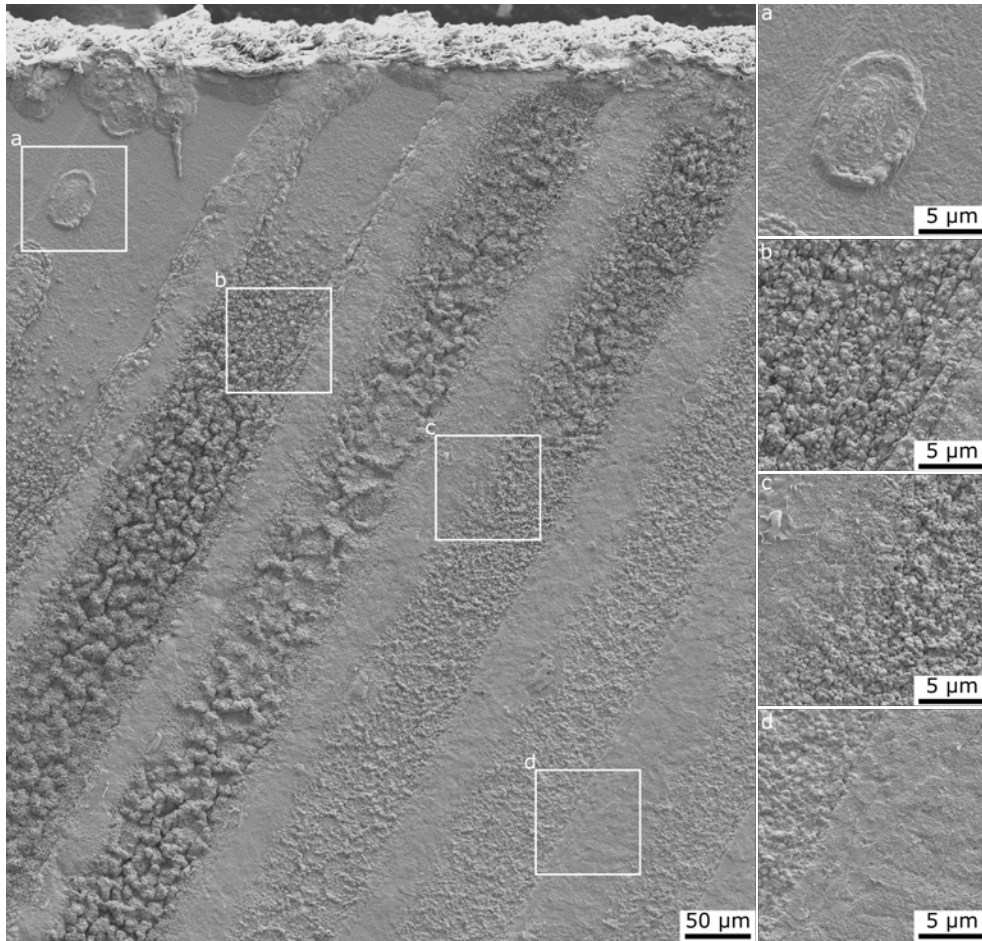


Figure 6: Flipped SEM images of patterned Zr surface after annealing in contact with polished Ag at 1073 K for 720 min under vacuum ($P = 1$ Pa).

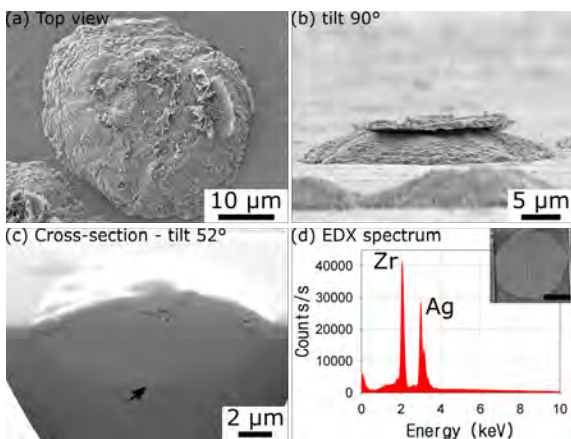


Figure 7: SEM characterisation of a typical protuberance. (a) top view. (b) Side view ($\approx 90^\circ$). (c) Cross-section SEM image of a protuberance after FIB sputter etching (tilt 52° , Pt deposit); the arrow indicates a second layer on the bottom. (d) EDX spectrum recorded after FIB sputter etching of a protuberance (see inset, scale bar = $5 \mu\text{m}$). AgZr is identified.

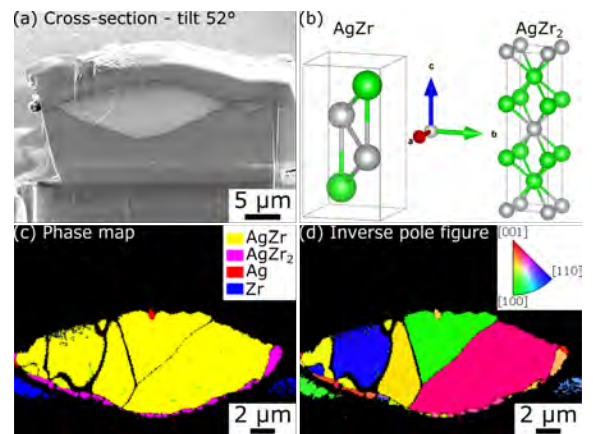


Figure 8: EBSD characterisation of a typical protuberance. (a) Foil of a protuberance prepared by FIB-SEM. (b) Crystalline structure of AgZr and AgZr₂ compounds identified in the literature; Ag atoms are in grey and Zr atoms in green. (c) Map of the phases identified by EBSD. (d) Inverse pole figure map along the x axis of the protuberance. In inset the unit triangle denotes the crystallographic orientations of the tetragonal structure common for both phases.

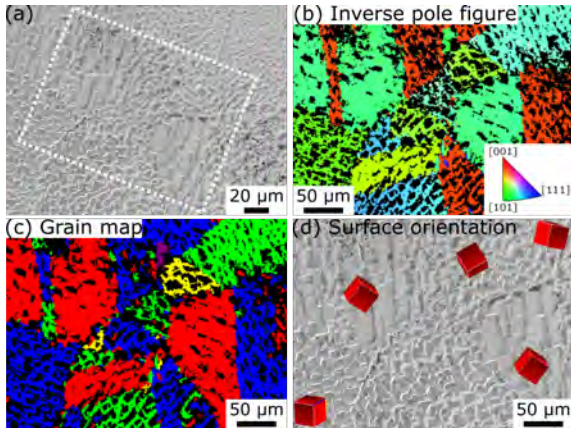


Figure 9: EBSD characterisation of faceted Ag surface. (a) SEM image of the scanned zone. (b) Inverse pole figure along the x axis of the Ag surface. (c) Grains map. (d) Crystal orientation of Ag grains.

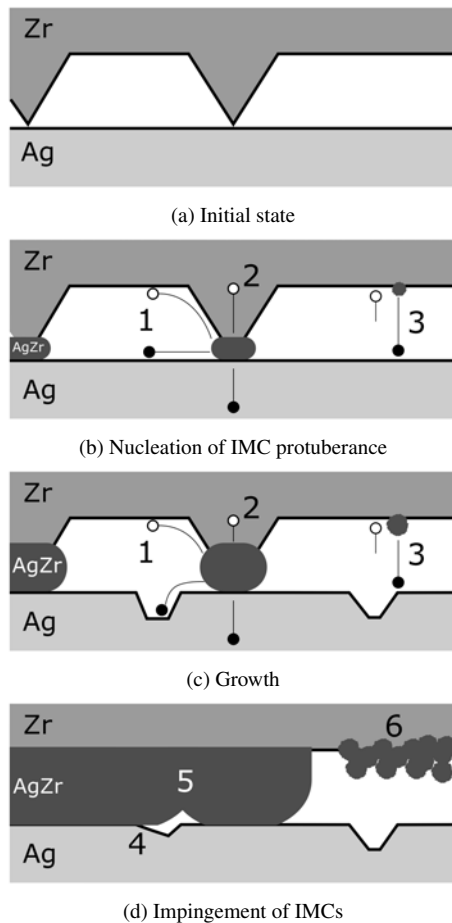


Figure 10: Model of surface modification for Ag-Zr couple.

4. Conclusion

The effect of contact reaction and thermal etching on the surface modifications of silver has been studied by annealing polished Ag and patterned Zr couples. Once Ag & Zr are detached, intermetallic compounds are observed on the Zr side while the Ag surface displays a large range of morphologies such as etch pits, faceting or holes. The intermetallic compounds have been identified as stoichiometric (poly-)crystalline AgZr and AgZr₂. A particular morphology called protuberance has been characterised as early stage growth site of IMCs on a contact point, the lateral growth and merging of these protuberances leading to an IMCs layer with time. At high temperature the nucleation and growth of IMCs is also possible *via* vapour transport of Ag atoms reaching the Zr surface in places far from the contact points. The mechanisms responsible of Ag surface modifications are driven by the minimisation of the total Gibbs energy and lead to the formation of facets oriented along the high-density crystal planes, {111} and {100}. The contribution of surface diffusion and free evaporation of Ag atoms to the Ag surface modifications have been identified during the nucleation and coalescence steps. The merging of local IMCs growth leads to the formation of a uniform layer, which in turn will smooth the Ag surface since the diffusion path for Ag atoms to react with Zr is smaller.

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